

Document Examiners

- Dennis J. Ryan
- Traci L. Moran
- Laura Hammond
- Kathleen M. Storer

Document Analysts

- Susan Fortunato
- Jeffrey Payne

All of our Document Examiners are certified by the ABFDE

(www.abfde.org)

Dennis Ryan named Irish Echo Emerald Entrepreneur

Applied Forensics founder Dennis J. Ryan was honored as a 2011 Irish Echo Emerald Entrepreneur on Friday, April 15th, at Rosie O'Grady's in New York, New York.

Ryan, a third-generation Irish-American, is one of six individuals to be given this award.

The Irish Echo Small Business 50 honors Irish-



Dennis Ryan and Councilman John C. Liu

American entrepreneurs and business leaders who have made significant con-

tributions to the American economy.

The Irish Echo, an Irish American weekly newspaper, said on their website that they picked "companies or individuals who have displayed entrepreneurial excellence and traditional Irish American can-do to make their enterprises stand-out in their field."

Jeffrey Payne joins Applied Forensics

Forensic analyst Jeffrey Payne joined the DC offices of Applied Forensics in fall 2010.

Payne has experience at a major federal laboratory. Jeff's expertise is in multifaceted complex examinations and determining the

methods used to produce questioned documents.

Payne has previously worked as a medical technologist in the microbiology department of Quest Diagnostics Inc.

Payne is also a member of a wide range of professional organizations including the American Society of Questioned Document Examiners and the Mid-Atlantic Association of Forensic Scientists.

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Document analysis program expedites search process

Applied Forensics counts Write-On among its most valued handwriting analysis tools.

Write-On is a document analysis program that collects, searches and manages large quantities of documents.

Forensic document examiners can use the program to quickly and efficiently review variations in handwriting samples.

The program follows a methodical process for data collection. A user

#	Occurrence	#	Occurrence
3	under (nevertheless) (Q1, Questioned)	4	concerning (concerning) (Q1, Bowman)
4	under (there) (Q1, Questioned)	5	concerning (services) (Q1, Bowman)
5	under (under) (Q1, Questioned)	6	concerning (different) (Q1, Bowman)
6	under (rather) (Q1, Questioned)	7	concerning (answering) (Q1, Bowman)
7	under (order) (Q1, Questioned)	8	concerning (order) (Q1, Bowman)
8	under (remember) (Q1, Questioned)	9	concerning (period)

An occurrence chart is a graphic compilation of the search results obtained by searching for a letter, a part or full word, or a combination of words. Occurrences can be placed side by side for visual comparison or tabulated in a report for presentation.

must scan his/her document, then enter a transcript of the document and information about its author.

After the user enters this informa-

tion for multiple documents, he/she can go back later and search the database for specific words or phrases. Write-On establishes a word index and occurrence charts based on the documents entered into the database.

Write-On has changed the way many document examiners search and collect data. Applied Forensics looks forward to continued use of this program in future cases.

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